

Atty.
Dkt. No.

M#

Client Ref.

256642

2000182

**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**

Applicant: JENDICK

Appln. No.: 09/412,362

Filing Date: October 5, 1999

Date: August 21, 2002

Page

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of

2

Examiner: L. Huynh

Group Art Unit: 3721

U.S. PATENT DOCUMENTS

Examiner's Initials*		Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
<i>LKH</i>	AR	3,281,024	10/1966	HENCHERT et al.			
<i>LKH</i>	BR	3,627,858	12/1971	PARTS et al.			
<i>LKH</i>	CR	3,796,344	05/1974	DE PHILLIPS et al.			
<i>LKH</i>	DR	3,822,496	07/1974	MINDER			
<i>LKH</i>	ER	3,958,354	05/1976	HOUGH et al.			
<i>LKH</i>	FR	4,331,256	05/1982	HELMS			
<i>LKH</i>	GR	4,465,204	08/1984	KAMINSKI et al.			
<i>LKH</i>	HR	4,517,436	05/1985	LAWRENCE			
<i>LKH</i>	IR	4,530,631	07/1985	KAMINSKI et al.			
<i>LKH</i>	JR	4,578,329	03/1986	HOLSAPPEL			
<i>LKH</i>	KR	4,765,532	08/1988	UOMOTI et al.			
<i>LKH</i>	LR	4,998,641	03/1991	WILLOUGHBY			
<i>LKH</i>	MR	5,191,695	03/1993	PAVELY et al.			
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FOREIGN PATENT DOCUMENTS

		Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract		Translation Readily Available	
						Enclosed	No	Enclose	No
<i>LKH</i>	OR	1,124,958	12/1965	UK					
<i>LKH</i>	PR	GB 2320008 A	06/1998	UK					
<i>LKH</i>	QR	WO 97/47397	12/1997	PCT					
<i>LKH</i>	RR	DE 19701547	03/1998	GERMANY		X			
<i>LKH</i>	SR	JP 63-20591	08/1988	JAPAN		X			
<i>LKH</i>	TR	JP 5-178346	07/1993	JAPAN		X			
<i>LKH</i>	UR	FR 2649628	01/1991	FRANCE		X			
<i>LKH</i>	VR	FR 2750396	01/1998	FRANCE		X			
<i>LKH</i>	WR	DE 4103746	08/1992	GERMANY		X			
<i>LKH</i>	XR	DE 29816109	07/1999	GERMANY				X	

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

	YR				
	ZR				
	AAR				
	BBR				
	CCR				
	DDR				

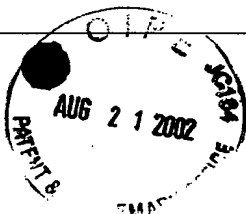
Examiner

Louis L. Huynh

Date Considered:

9/12/02

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.



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U.S. PATENT DOCUMENTS

Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
<i>AKH</i>	EER 5,416,951	05/1995	KEYAKI et al.			
<i>AKH</i>	FFR 5,492,077	02/1996	ROSE			
<i>AKH</i>	GGR 5,523,125	06/1996	KENNEDY et al.			
<i>AKH</i>	HHR 5,635,900	08/1997	CLEMENT et al.			
<i>AKH</i>	IIR 5,799,815	09/1998	LANG			
<i>AKH</i>	JJR 5,855,969	01/1999	ROBERTSON			
<i>AKH</i>	KKR 6,002,098	12/1999	PIRCHER et al.			
<i>AKH</i>	LLR DES. 210,870	04/1968	MARKERT			
<i>AKH</i>	MMR DES. 261,364	10/1981	SMYTH			
<i>AKH</i>	NNR DES. 268,250	03/1983	SMYTH			
<i>AKH</i>	OOR DES. 289,017	03/1987	SPANGLER et al.			
	PPR					
	QQR					
	RRR					

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FOREIGN PATENT DOCUMENTS							English Abstract		Translation Readily Available	
		Document Number	Date MM/YYYY	Country	Inventor Name					
							Enclosed	No	Enclose	No
AKH	SSR	EP 0289022	11/1988	EUROPE						
AKH	TTR	DE 2052512	04/1972	GERMANY					X	
AKH	UUR	EP 0208175	01/1987	EUROPE						
	VVR									
	WW									
	XXR									
	YYR									
	ZZR									
	AAA									
	BBB									

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

	CCC				
	DDD				
	EEE				
	FFF				
	GGG				
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Examiner *L. Huynh* Date Considered: *9/12/02*

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